

NPN SILICON TRANSISTOR

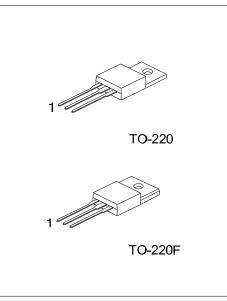
NPN BIPOLAR POWER TRANSISTOR FOR SWITCHING POWER SUPPLY APPLICATIONS

DESCRIPTION

The UTC **MJE13007** is designed for high-voltage, high-speed power switching inductive circuits where fall time is critical. It is particularly suited for 115 and 220 V switch mode applications.

FEATURES

- $V_{CEO(SUS)}400V$
- * 700V Blocking Capability



Lead-free: MJE13007L Halogen-free:MJE13007G

ORDERING INFORMATION

Ordering Number			Daakaga	Pin Assignment			Deaking	
Normal	Lead Free	Halogen Free	Package	1	2	3	Packing	
MJE13007-TA3-T	MJE13007L-TA3-T	MJE13007G-TA3-T	TO-220	В	С	E	Tube	
MJE13007-TF3- T	MJE13007L-TF3- T	MJE13007G-TF3- T	TO-220F	В	С	E	Tube	

MJE13007L- <u>TA3-T</u> (1)Packing Type (2)Package Type (3)Lead Plating	(1)T: Tube (2) TA3: TO-220, TF3: TO-220F (3) G: Halogen Free, L: Lead Free, Blank: Pb/Sn
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■ ABSOLUTE MAXIMUM RATING

PARAMETER		SYMBOL	RATINGS	UNIT
Collector-Emitter Sustaining Voltage		V _{CEO}	400	V
Collector-Emitter Breakdown Voltage		V _{CBO}	700	V
Emitter-Base Voltage		V _{EBO}	9.0	V
Collector Current	Continuous	Ι _C	8.0	А
	Peak (1)	I _{CM}	16	А
Dana Ourrant	Continuous	Ι _Β	4.0	А
Base Current	Peak (1)	I _{BM}	8.0	А
Emitter Current	Continuous	Ι _Ε	12	А
	Peak (1)	I _{EM}	24	А
Total Device Dissipation	T _C = 25°C	PD	80	W
Operating and Storage Junction Temperature		T _{J,} T _{STG}	-55~+150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

THERMAL DATA

PARAMETER		RATINGS	UNIT	
Junction to Case	θ _{JC}	1.56	°C/W	
Junction to Ambient	θ_{JA}	62.5	°C/W	

Note 1: Pulse Test: Pulse Width = 5.0 ms, Duty Cycle $\leq 10\%$.

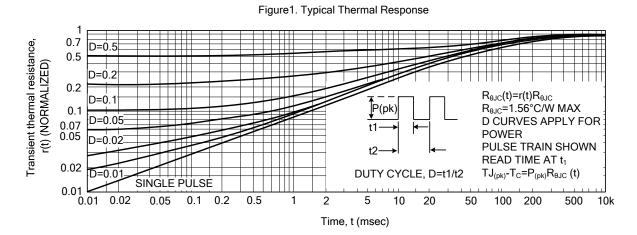
Measurement made with thermocouple contacting the bottom insulated mounting surface of the package (in a location beneath the die), the device mounted on a heatsink with thermal grease applied at a mounting torque of 6 to 8•lbs.

■ ELECTRICAL CHARACTERISTICS (T_c=25°C, unless otherwise noted)

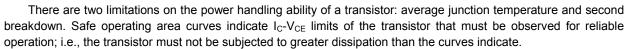
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
Collector-Emitter Sustaining Voltage	V _{CEO(SUS)}	I _C =10mA, I _B =0	400			V		
Collector Cutoff Current	I _{CBO}	V _{CES} =700V			0.1	mA		
		V _{CES} =700V, T _C =125°C			1.0	mA		
Emitter Cutoff Current	I _{EBO}	V _{EB} =9.0V, I _C =0			100	μA		
DC Current Gain	h _{FE1}	I _C =2.0A, V _{CE} =5.0V	8.0		40			
	h _{FE2}	I _C =5.0A, V _{CE} =5.0V	5.0		30			
		I _C =2.0A, I _B =0.4A			1.0	V		
Collector-Emitter Saturation Voltage	V _{CE(SAT)}	I _C =5.0A, I _B =1.0A			2.0	V		
		I _C =8.0A, I _B =2.0A			3.0	V		
		I _C =5.0A, I _B =1.0A, T _C =100°C			3.0	V		
	$V_{BE(SAT)}$	I _C =2.0A, I _B =0.4A			1.2	V		
Base-Emitter Saturation Voltage		I _C =5.0A, I _B =1.0A			1.6	V		
		I _C =5.0A, I _B =1.0A, T _C =100°C			1.5	V		
Current-Gain-Bandwidth Product	f⊤	I _C =500mA, V _{CE} =10V, f=1.0 MHz	4.0	14		MHz		
Output Capacitance	C _{ob}	V _{CB} =10V, I _E =0, f=0.1MHz		80		pF		
Resistive Load (Table 1)								
Delay Time				0.025	0.1	μs		
Rise Time	t _R	V_{CC} =125V, I _C =5.0A,		0.5	1.5	μs		
Storage Time	ts	I _{B1} =I _{B2} =1.0A, t _p =25µs, Duty Cycle≤1.0%		1.8	3.0	μs		
Fall Time	t _F			0.23	0.7	μs		

* Pulse Test: Pulse Width≤300µs, Duty Cycle≤2.0%





■ TYPICAL THERMAL RESPONSE

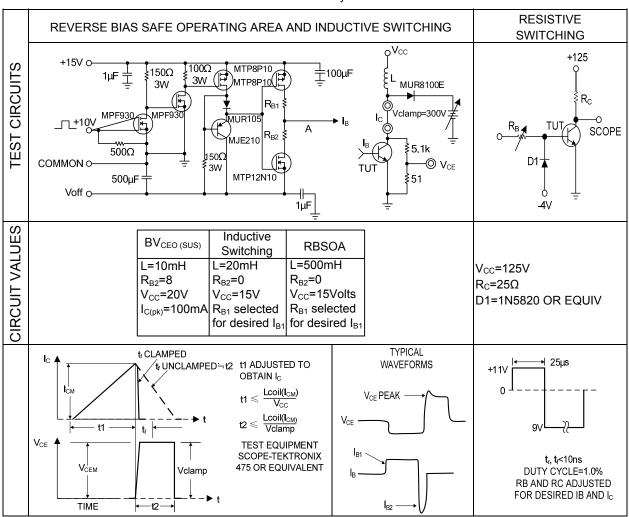


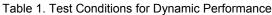
The data of Figure 7 is based on $T_c = 25^{\circ}C$; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be debated when $T_c \ge 25^{\circ}C$. Second breakdown limitations do not debate the same as thermal limitations. Allowable current at the voltages shown on Figure 7 may be found at any case temperature by using the appropriate curve on Figure 9.

At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

Use of reverse biased safe operating area data (Figure 8) is discussed in the applications information section.









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TYPICAL CHARACTERISTICS

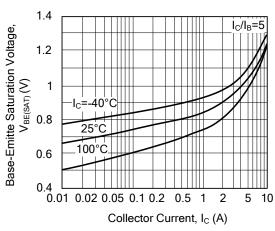
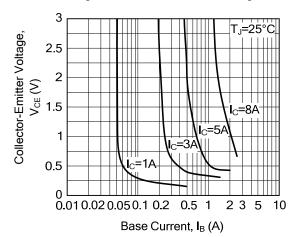
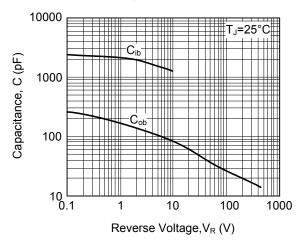


Figure 2. Base-Emitter Saturation Voltage

Figure 4. Collector Saturation Region









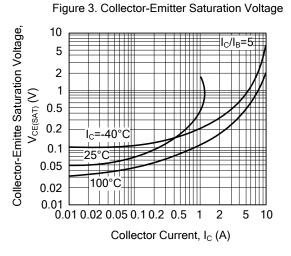


Figure 5. DC Current Gain

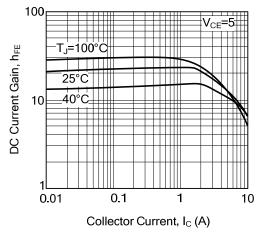
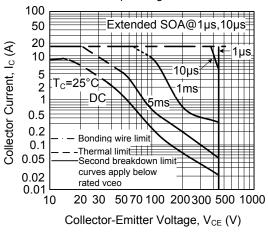
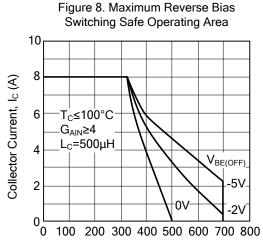


Figure 7. Maximum Forward Bias Safe **Operating Area**



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TYPICAL CHARACTERISTICS



Collector-Emitter Clamp Voltage, V_{CEV} (V)

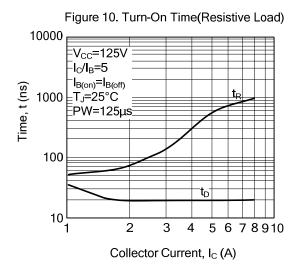
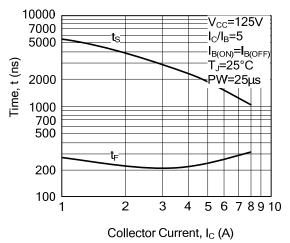


Figure 9. Forward Bias Power Derating 1 SECOND BREAKDOWN Power Derating Factor 0.8 DERATING 0.6 THERMAL 0.4 DERATING 0.2 0 40 60 80 100 120 140 160 20 Case Temperature, T_C (°C)





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